

EE 330

Lecture 39

Digital Circuits

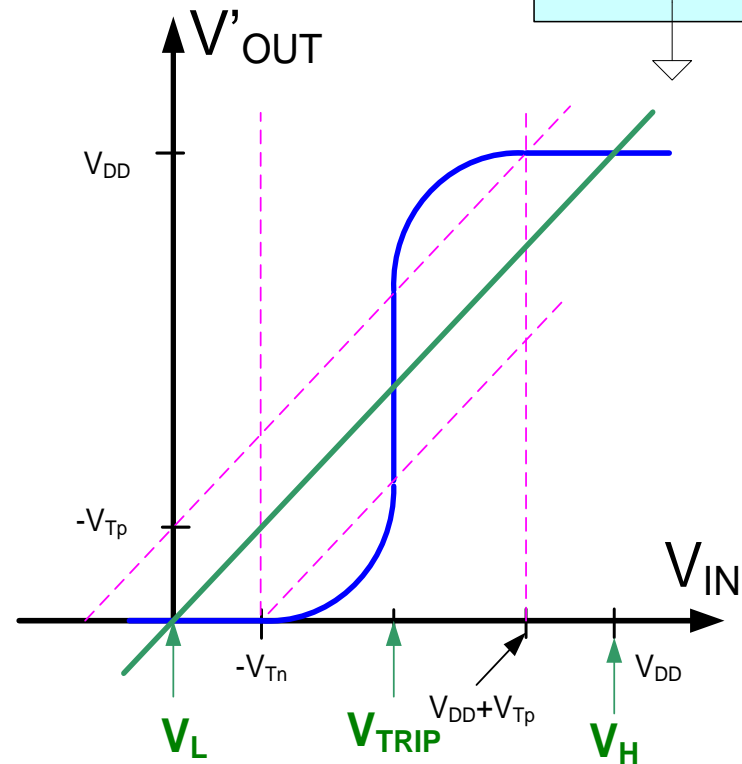
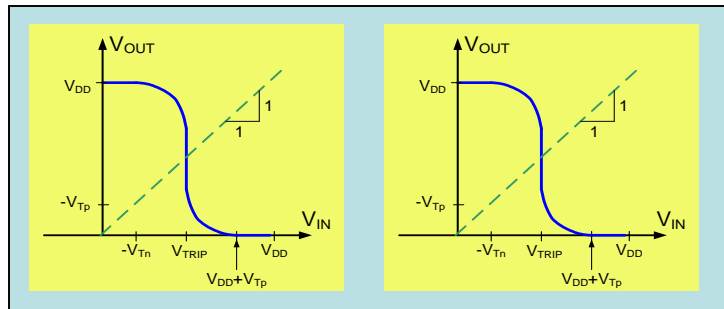
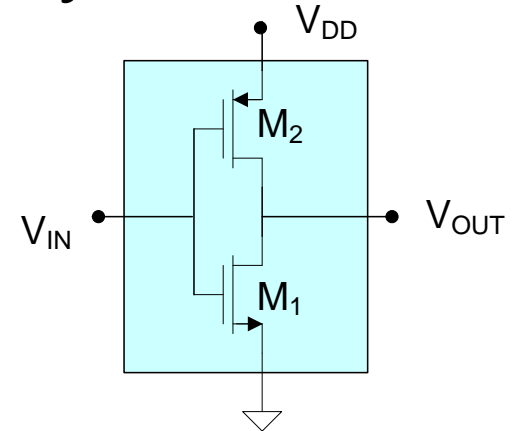
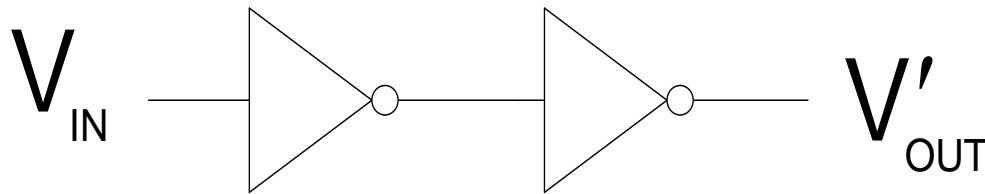
Other MOS Logic Families

Propagation Delay – basic characterization

Device Sizing (Inverter and multiple-input gates)

Review from last lecture

Inverter Transfer Characteristics of Inverter Pair for THIS Logic Family

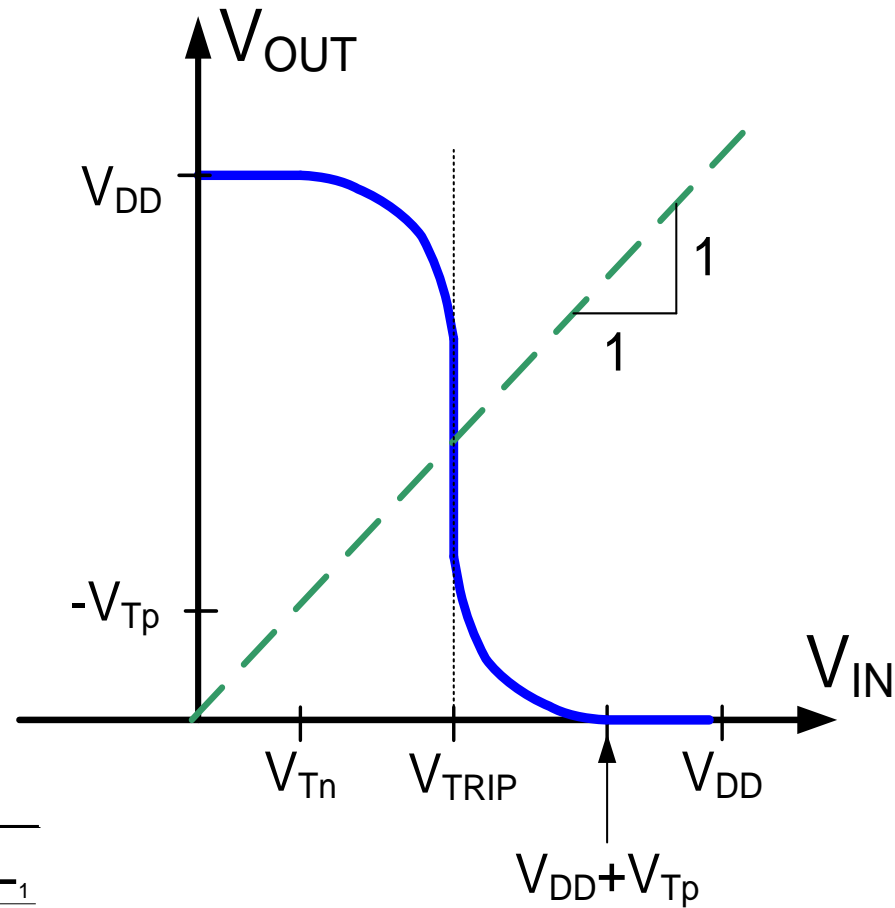


$$V_H = V_{DD} \text{ and } V_L = 0$$

Note this is independent of device sizing for THIS logic family !!

Review from last lecture

Transfer characteristics of the static CMOS inverter (Neglect λ effects)

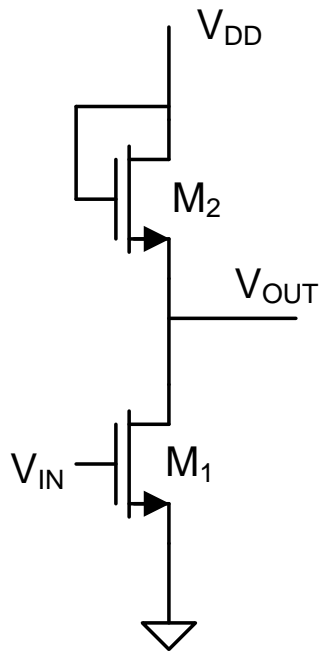


From Case 3 analysis:

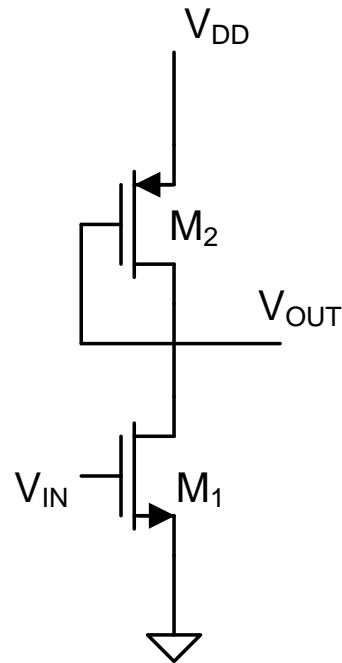
$$V_{IN} = \frac{(V_{Tn}) + (V_{DD} + V_{Tp}) \sqrt{\frac{\mu_p}{\mu_n} \frac{W_2}{W_1} \frac{L_1}{L_2}}}{1 + \sqrt{\frac{\mu_p}{\mu_n} \frac{W_2}{W_1} \frac{L_1}{L_2}}}$$

Review from last lecture

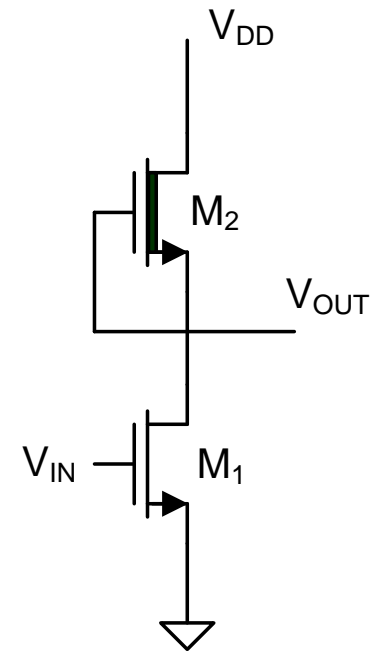
Other MOS Logic Families



Enhancement
Load NMOS



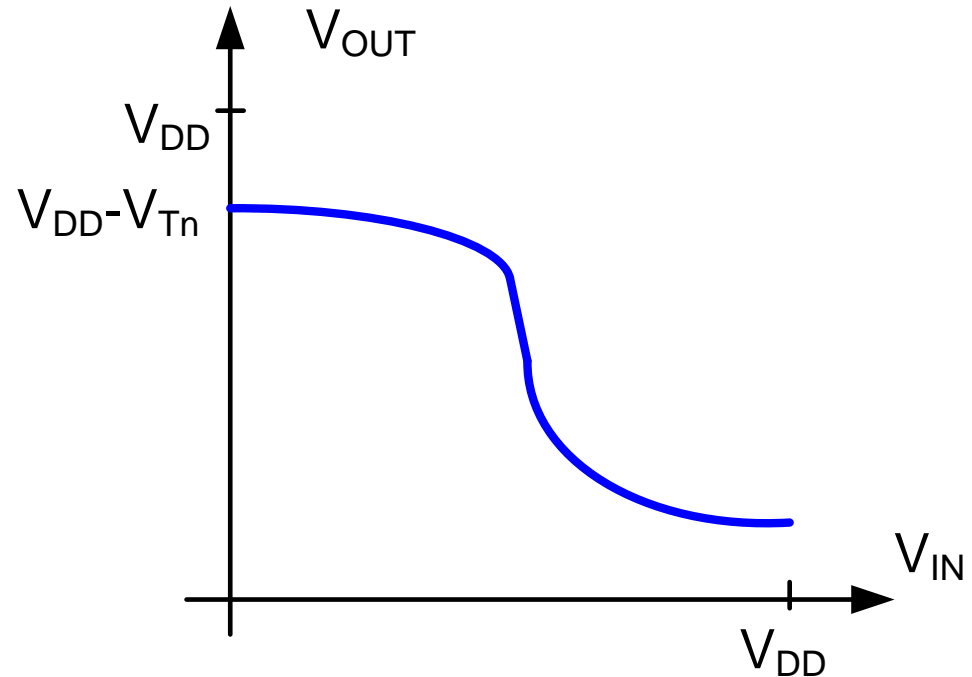
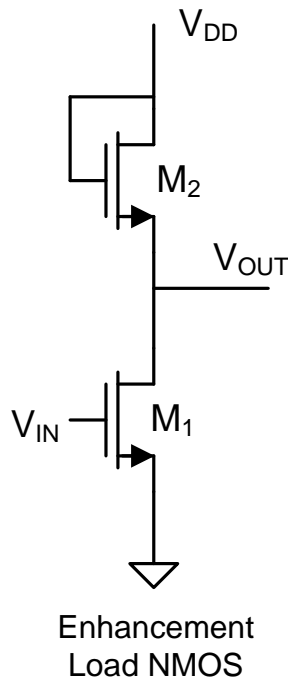
Enhancement Load
Pseudo-NMOS



Depletion
Load NMOS

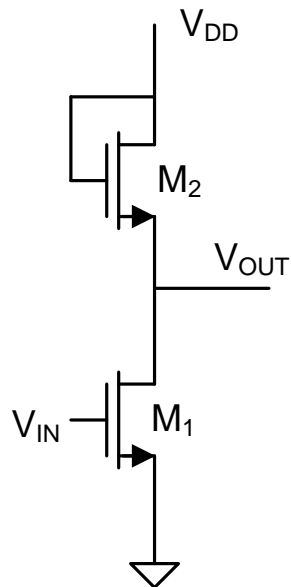
Review from last lecture

Other CMOS/MOS Logic Families

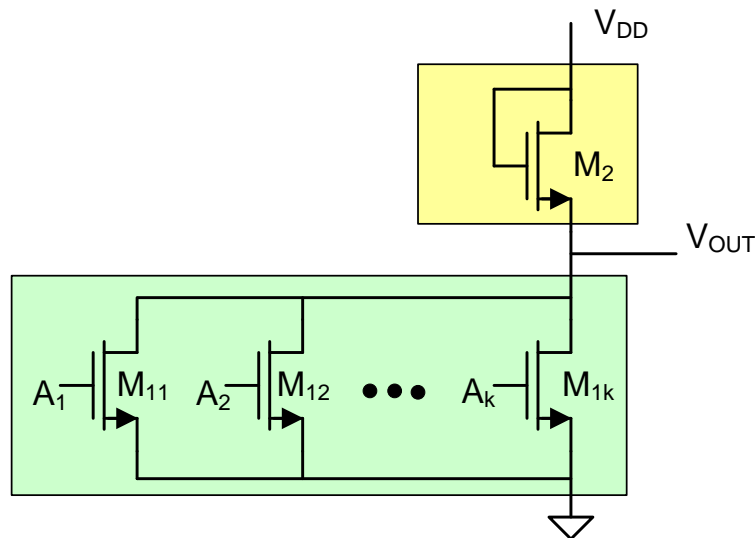


- High and low swings are reduced 😞
- Response time is slow on LH output transitions 😞
- Static Power Dissipation Large when V_{OUT} is low (will show) 😞
- Very economical process 😊
- Termed “ratio logic” (because logic values dependent on device W/L ratios – USE UP DOF!)
- May not work for some device sizes
- Compact layout (no wells !) 😊
- Available to use in standard CMOS process 😊

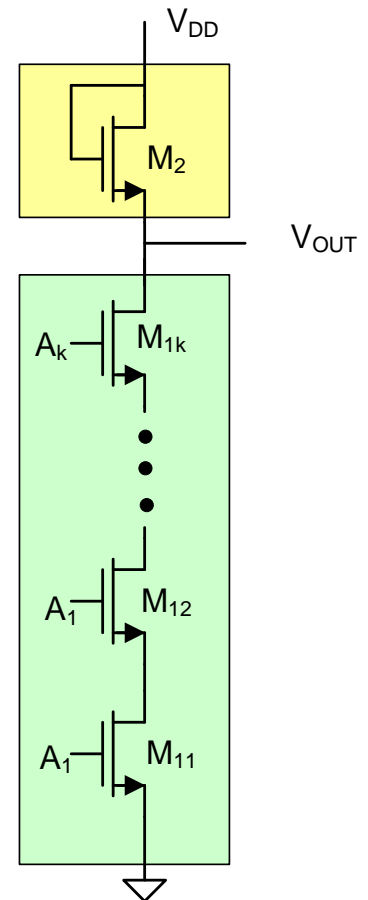
Other CMOS/MOS Logic Families



Enhancement
Load NMOS



k -input NOR



k -input NAND

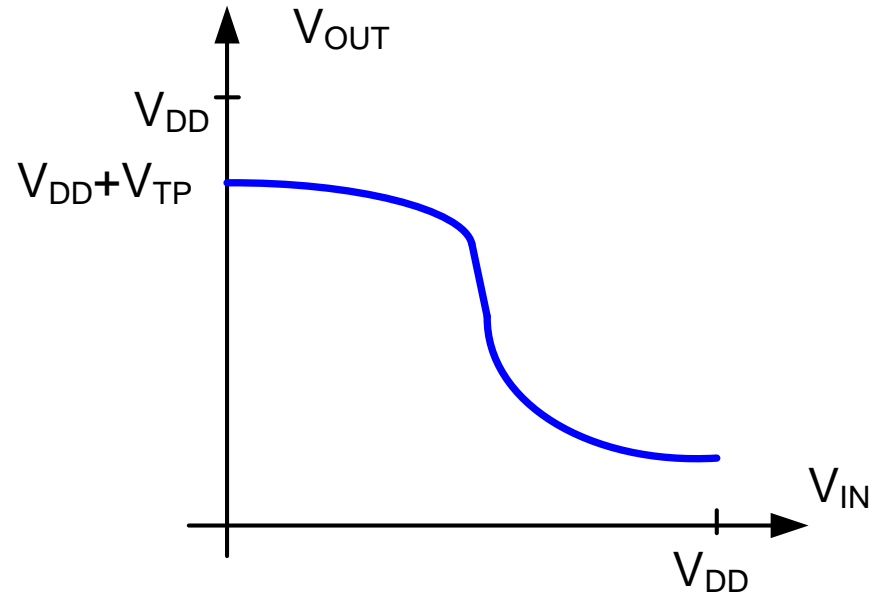
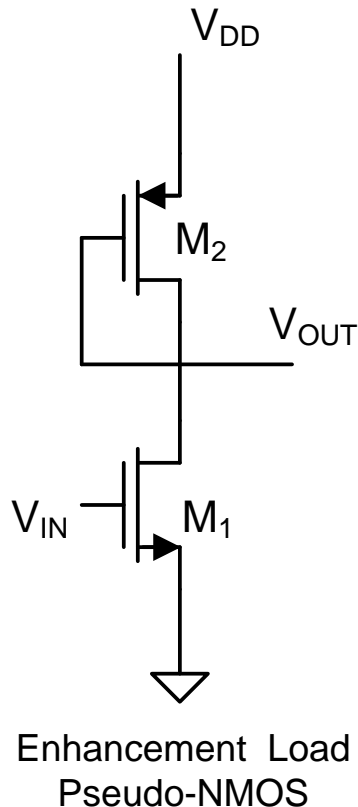
- Multiple-input gates require single transistor for each additional input



- Still useful if many inputs are required
(will be shown that static power does not increase with k)



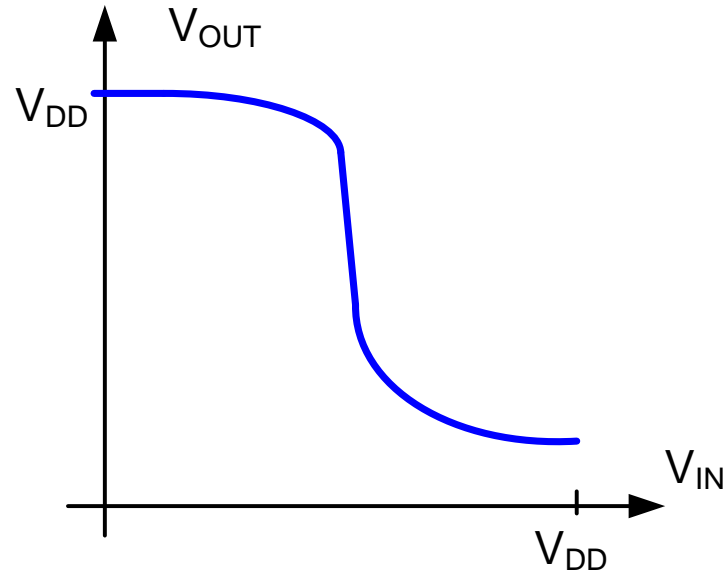
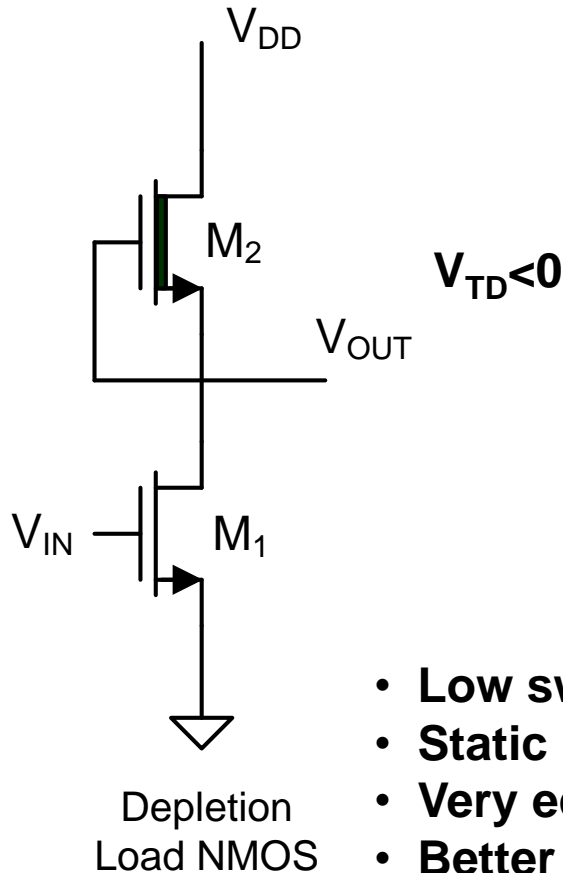
Other CMOS/MOS Logic Families



- High and low swings are reduced
- Response time is slow on LH output transitions
- Static Power Dissipation Large when V_{OUT} is low
- Multiple-input gates require single transistor for each additional input
- Termed “ratio” logic
- Available to use in standard CMOS process

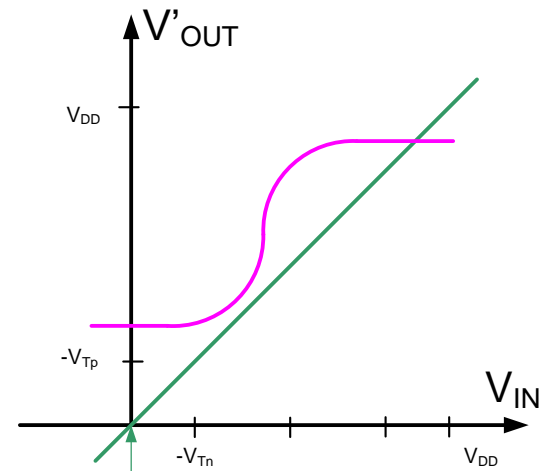
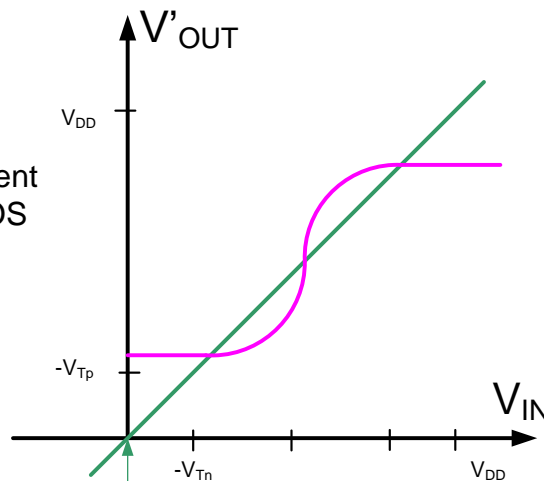
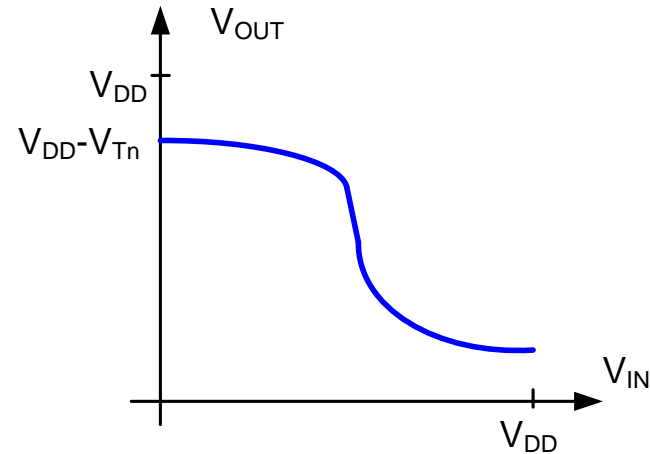
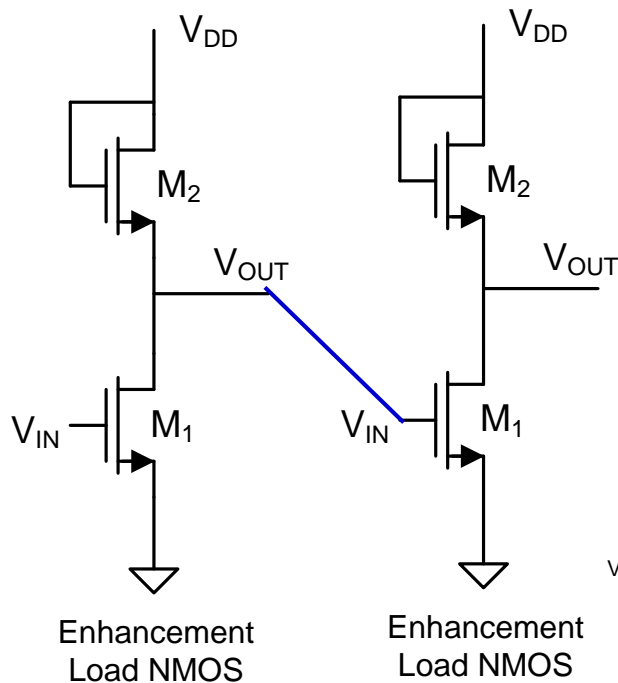


Other CMOS/MOS Logic Families



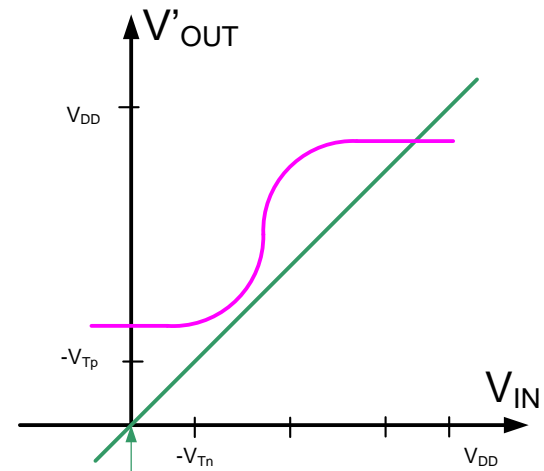
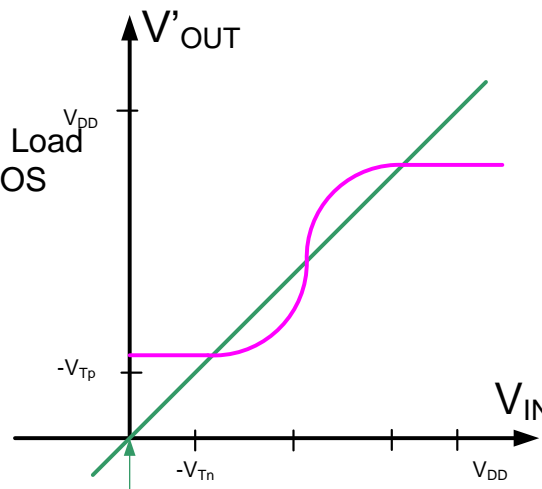
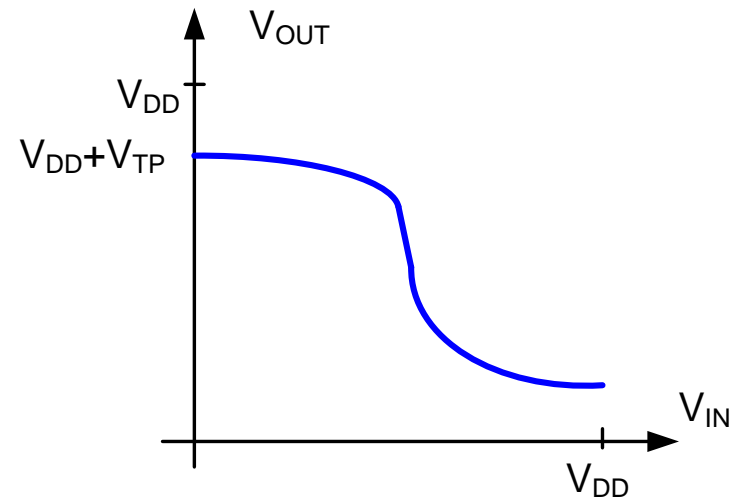
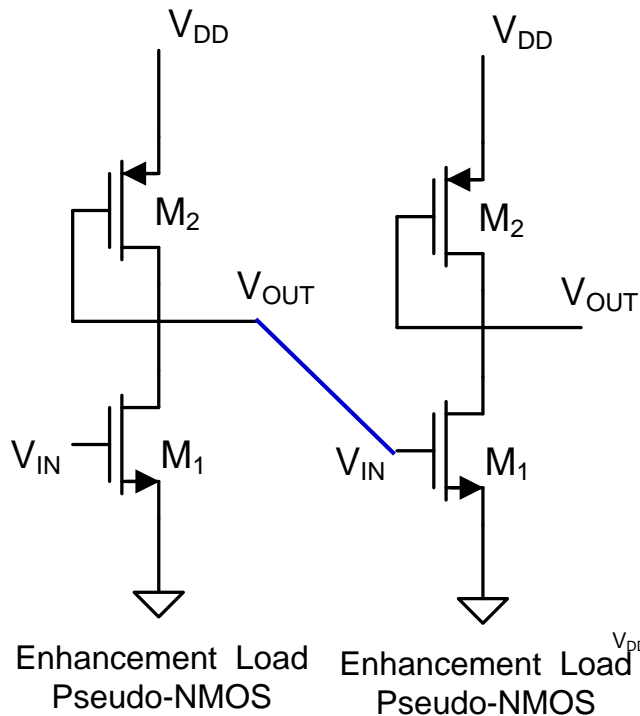
- Low swing is reduced 😞
- Static Power Dissipation Large when V_{OUT} is low 😞
- Very economical process 😊
- Better than Enhancement Load NMOS
- Termed “ratio” logic
- Compact layout (no wells !) 😊
- Response time slow on L-H output transitions 😞
- Dominant MOS logic until about 1985
- Depletion device not available in most processes today 😞

Other CMOS/MOS Logic Families



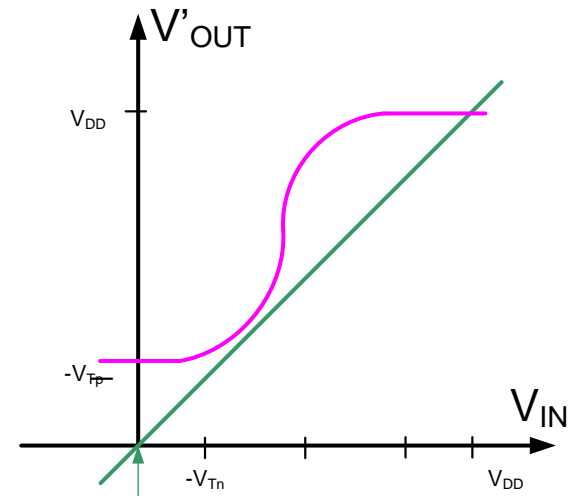
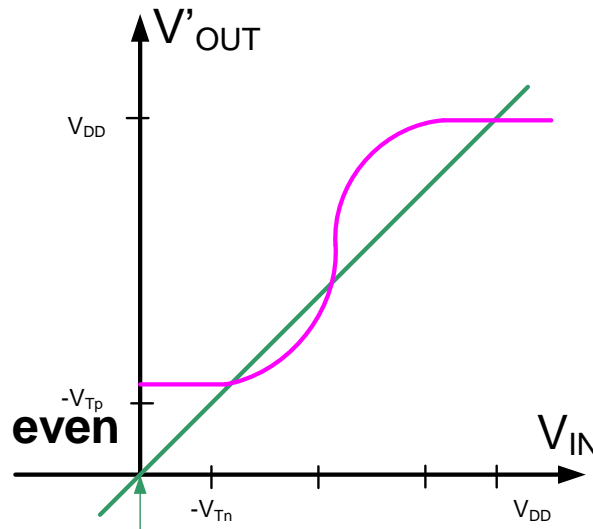
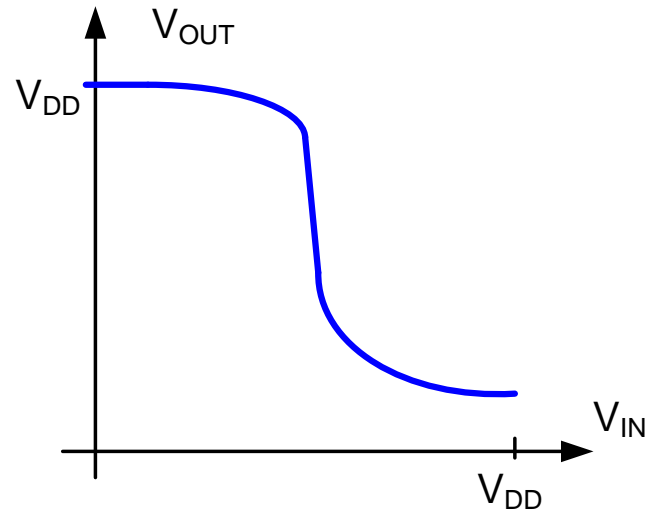
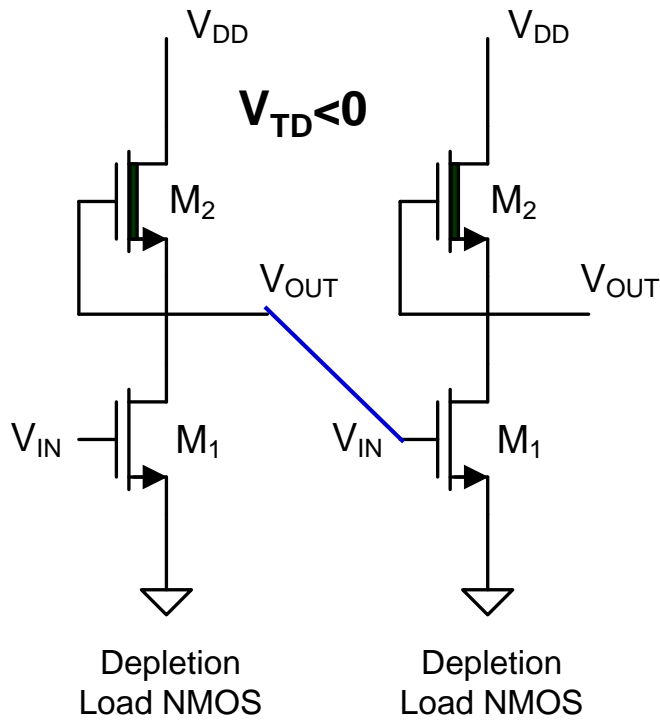
- **Reduced $V_H - V_L$**
- **Device sizing critical for even basic operation**
- **Shallow slope at V_{TRIP}**

Other CMOS/MOS Logic Families



- **Reduced $V_H - V_L$**
- **Device sizing critical for even basic operation (DOF)**
- **Shallow slope at V_{TRIP}**

Other CMOS/MOS Logic Families



- Reduced $V_H - V_L$
- Device sizing critical for even basic operation
- Shallow slope at V_{TRIP}

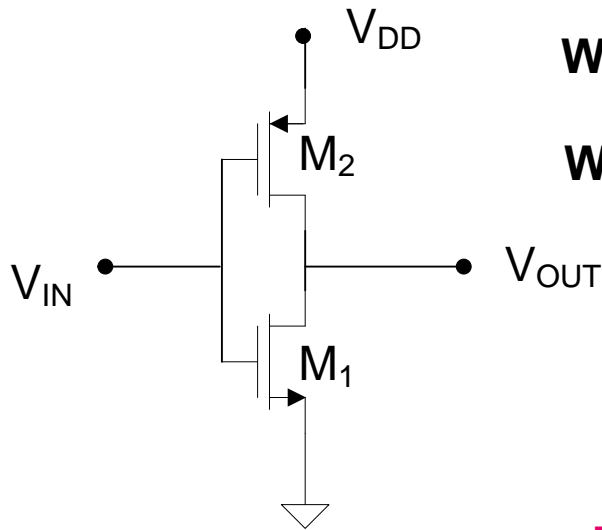
Digital Circuit Design

- Hierarchical Design
- Basic Logic Gates
- Properties of Logic Families
- Characterization of CMOS Inverter
- Static CMOS Logic Gates
 - Ratio Logic
- Propagation Delay
 - Simple analytical models
 - Elmore Delay
- Sizing of Gates
- Propagation Delay with Multiple Levels of Logic
- Optimal driving of Large Capacitive Loads
- Power Dissipation in Logic Circuits
- Other Logic Styles
- Array Logic
- Ring Oscillators

→ **done**

→ **partial**

Static Power Dissipation in Static CMOS Family

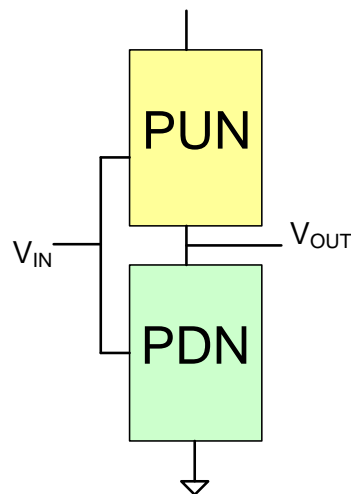


When V_{IN} is Low and V_{OUT} is High, M_1 is off and $I_{D1}=0$

When V_{IN} is High and V_{OUT} is Low, M_2 is off and $I_{D2}=0$

Thus, $P_{STATIC}=0$

This is a key property of the static CMOS Logic Family → the major reason Static CMOS Logic is so dominant

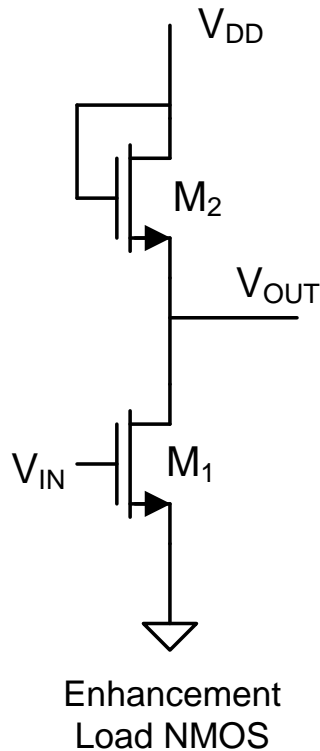


It can be shown that this zero static power dissipation property can be preserved if the PUN is comprised of p-channel devices, the PDN is comprised of n-channel devices and they are never both driven into the conducting states at the same time

Compound Gate in CMOS Process

Static Power Dissipation in Ratio Logic Families

Example:



Assume $V_{DD}=5V$

$V_T=1V$, $\mu C_{OX}=10^{-4}A/V^2$, $W_1/L_1=1$ and M_2 sized so that V_L is close to V_{Tn}

Observe:

$$V_H = V_{DD} - V_{Tn}$$

If $V_{IN}=V_H$, $V_{OUT}=V_L$ so

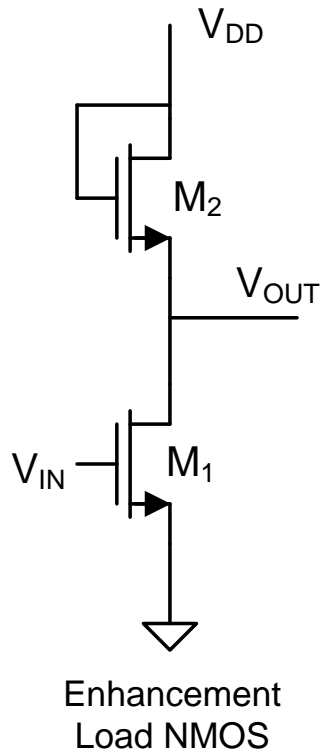
$$I_{D1} = \frac{\mu C_{OX} W_1}{L_1} \left(V_{GS1} - V_T - \frac{V_{DS1}}{2} \right) V_{DS1}$$

$$I_{D1} = 10^{-4} \left(5 - 1 - 1 - \frac{1}{2} \right) \cdot 1 = 0.25mA$$

$$P_L = (5V)(0.25mA) = 1.25mW$$

Static Power Dissipation in Ratio Logic Families

Example:



Assume $V_{DD}=5V$

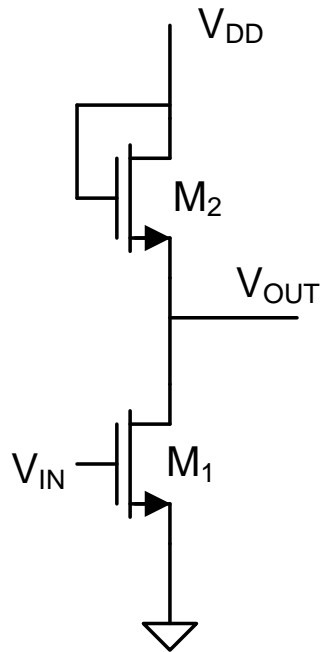
$V_T=1V$, $\mu C_{OX}=10^{-4}A/V^2$, $W_1/L_1=1$ and M_2 sized so that V_L is close to V_{Tn}

$$P_L=(5V)(0.25mA)=1.25mW$$

If a circuit has 100,000 gates and half of them are in the $V_{OUT}=V_L$ state, the static power dissipation will be

Static Power Dissipation in Ratio Logic Families

Example:



Enhancement
Load NMOS

Assume $V_{DD}=5V$

$V_T=1V$, $\mu C_{OX}=10^{-4}A/V^2$, $W_1/L_1=1$ and M_2 sized so that V_L is close to V_{Tn}

$$P_L=(5V)(0.25mA)=1.25mW$$

If a circuit has 100,000 gates and half of them are in the $V_{OUT}=V_L$ state, the static power dissipation will be

$$P_{STATIC} = \frac{1}{2} 10^5 \bullet 1.25mW = \mathbf{62.5W}$$

This power dissipation is way too high and would be even larger in circuits with 100 million or more gates – the level of integration common in SoC circuits today

Digital Circuit Design

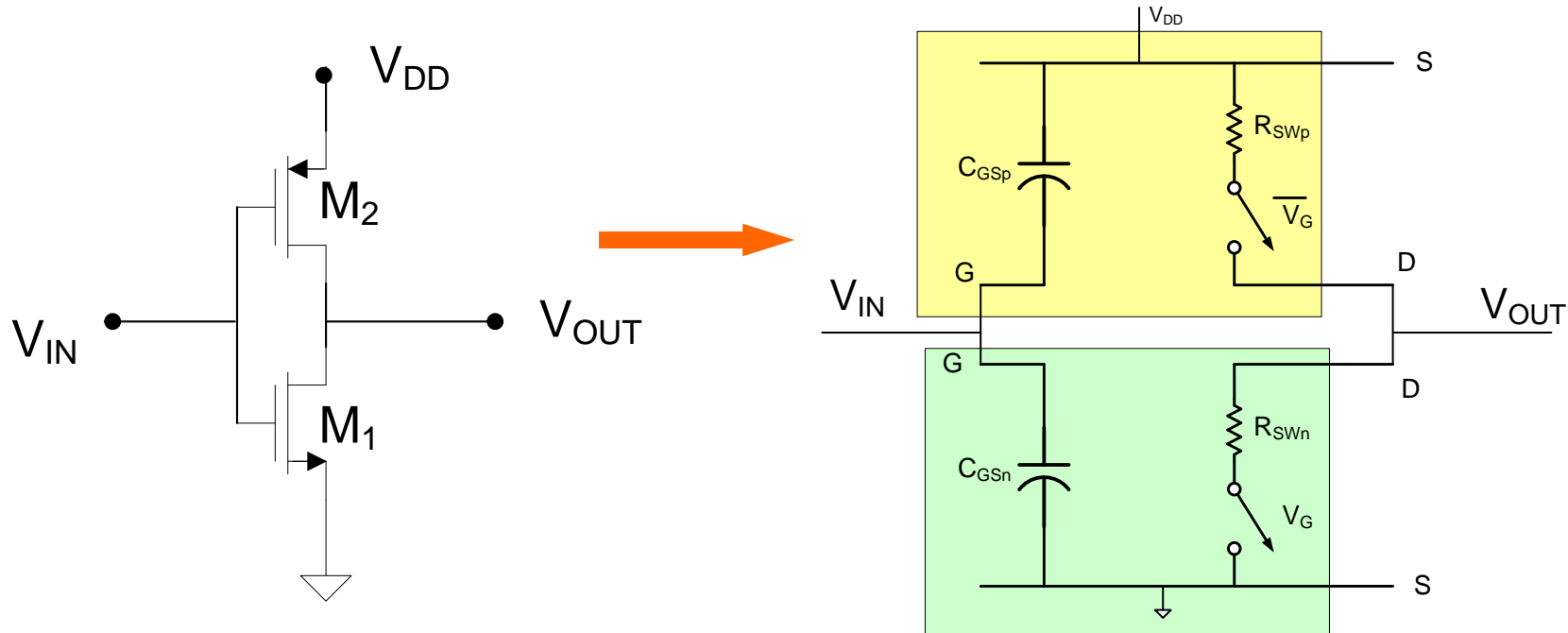
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- Ring Oscillators

→ **done**

→ **partial**

Propagation Delay in Static CMOS Family

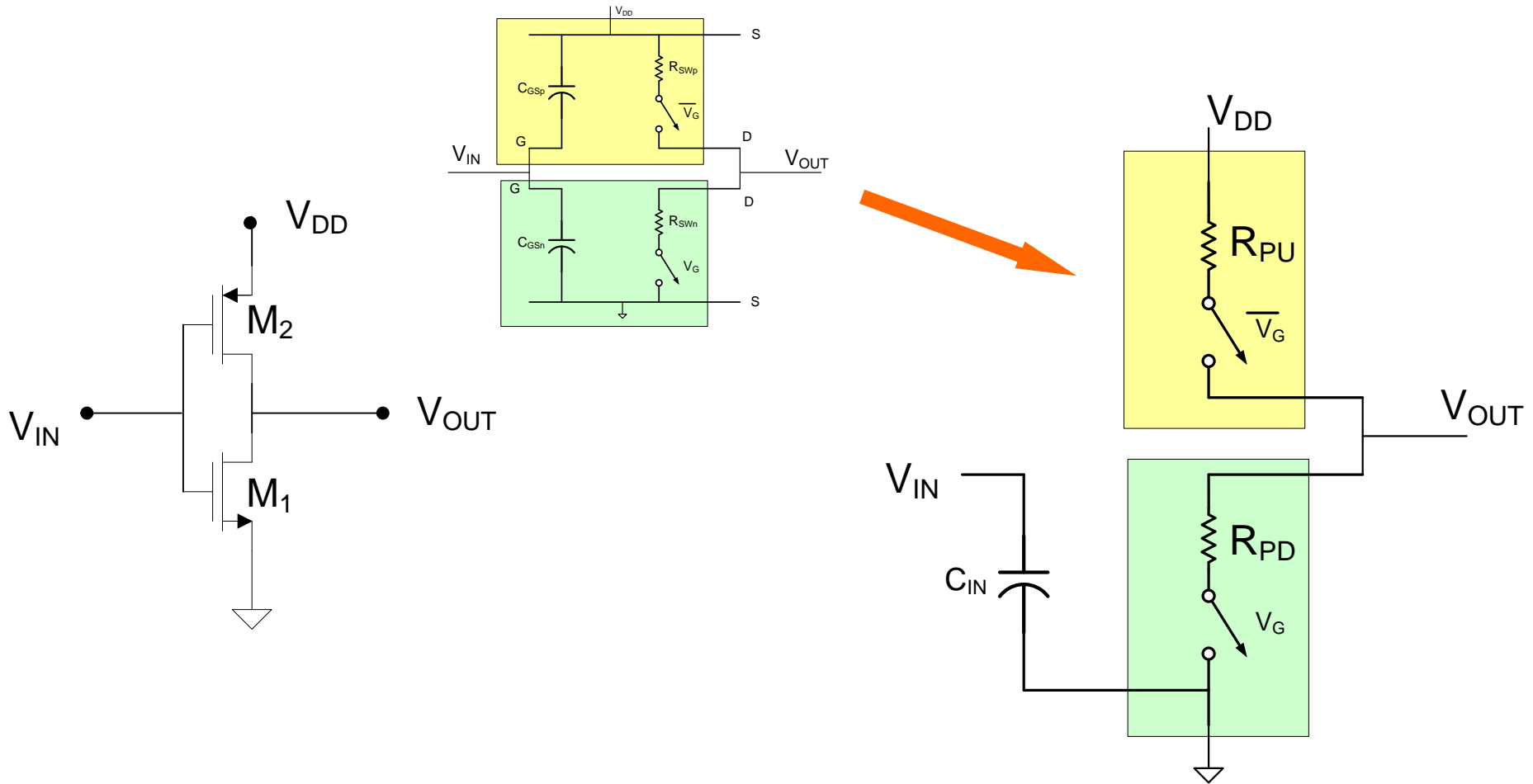
(Review from earlier discussions)



Switch-level model of Static CMOS inverter (neglecting diffusion parasitics)

Propagation Delay in Static CMOS Family

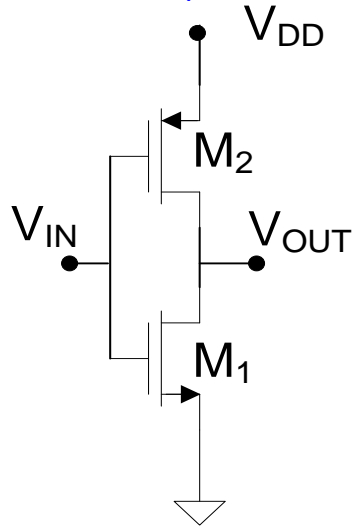
(Review from earlier discussions)



Switch-level model of Static CMOS inverter (neglecting diffusion parasitics)

Propagation Delay in Static CMOS Family

(Review from earlier discussions)



Since operating in triode through most of transition:

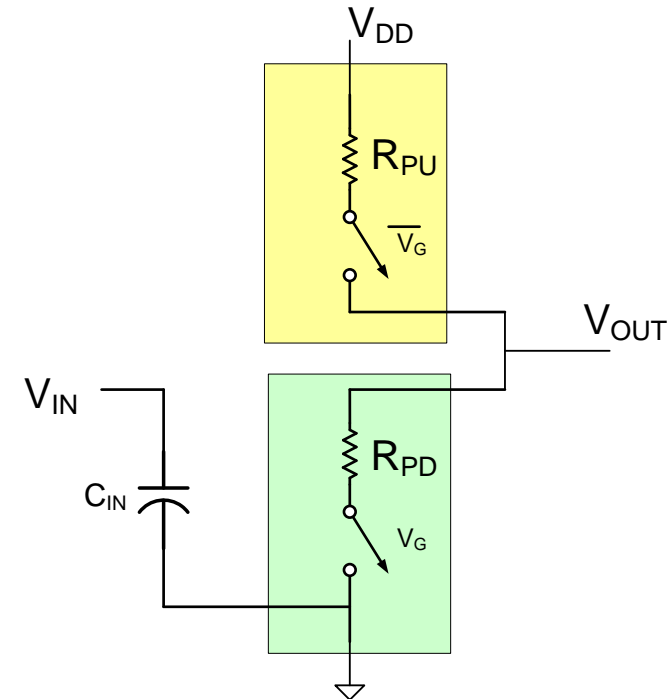
$$I_D \cong \frac{\mu C_{ox} W}{L} \left(V_{GS} - V_T - \frac{V_{DS}}{2} \right) V_{DS} \cong \frac{\mu C_{ox} W}{L} (V_{GS} - V_T) V_{DS}$$

$$R_{PD} = \frac{V_{DS}}{I_D} = \frac{L_1}{\mu_n C_{ox} W_1 (V_{DD} - V_{Tn})}$$

$$I_D = \frac{\mu C_{ox} W}{L} \left(V_{GS} - V_T - \frac{V_{DS}}{2} \right) V_{DS} \cong \frac{\mu C_{ox} W}{L} (V_{GS} - V_T) V_{DS}$$

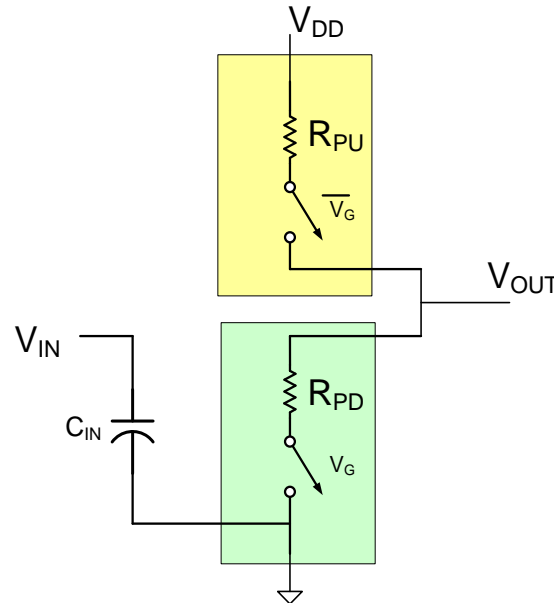
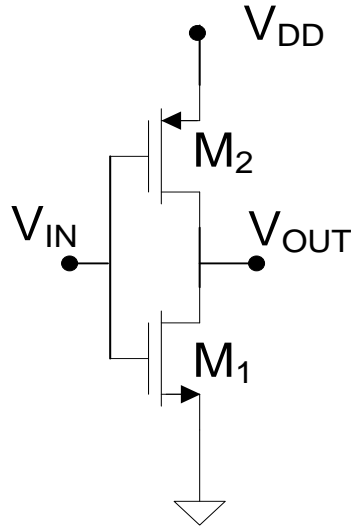
$$R_{PU} = \frac{V_{DS}}{I_D} = \frac{L_2}{\mu_p C_{ox} W_2 (V_{DD} + V_{Tp})}$$

$$C_{IN} = C_{ox} (W_1 L_1 + W_2 L_2)$$



Propagation Delay in Static CMOS Family

(Review from earlier discussions)



$$R_{PD} = \frac{L_1}{\mu_n C_{OX} W_1 (V_{DD} - V_{Tn})}$$

$$R_{PU} = \frac{L_2}{\mu_p C_{OX} W_2 (V_{DD} + V_{Tp})}$$

$$C_{IN} = C_{OX} (W_1 L_1 + W_2 L_2)$$

Example: Minimum-sized M_1 and M_2

If $\mu_n C_{OX} = 100 \mu A V^{-2}$, $C_{OX} = 4 \text{ fF} \mu^{-2}$, $V_{Tn} = V_{DD}/5$, $V_{Tp} = -V_{DD}/5$, $\mu_n/\mu_p = 3$, $L_1 = W_1 = L_{MIN}$, $L_2 = W_2 = L_{MIN}$, $L_{MIN} = 0.5 \mu$ and $V_{DD} = 5V$

(Note: This C_{OX} is somewhat larger than that in the 0.5u ON process)

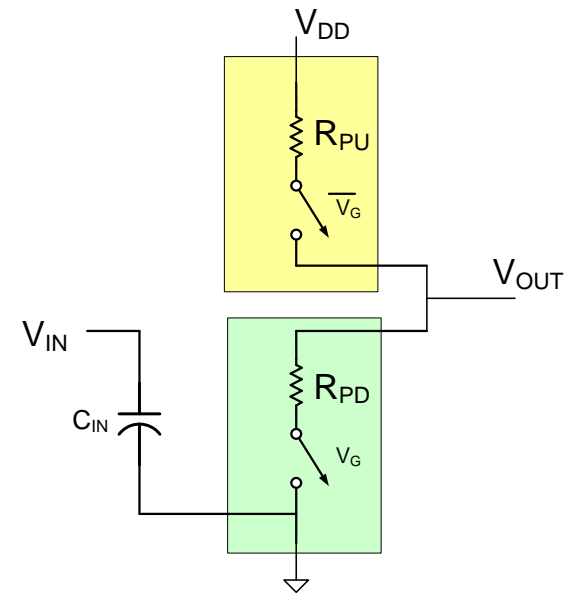
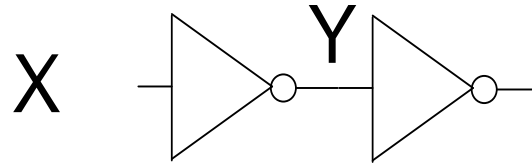
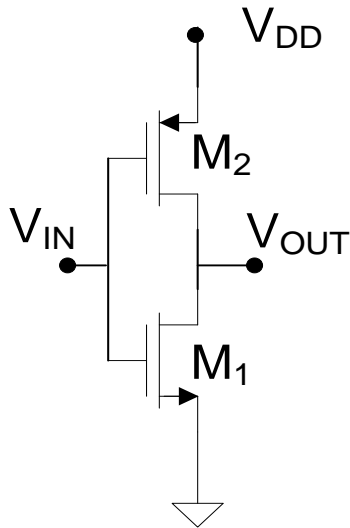
$$R_{PD} = \frac{1}{10^{-4} \cdot 0.8 V_{DD}} = 2.5 K\Omega$$

$$C_{IN} = 4 \cdot 10^{-15} \cdot 2 L_{MIN}^2 = 2 \text{ fF}$$

$$R_{PU} = \frac{1}{10^{-4} \cdot \frac{1}{3} \cdot 0.8 V_{DD}} = 7.5 K\Omega$$

Propagation Delay in Static CMOS Family

(Review from earlier discussions)



In typical process with **Minimum-sized M_1 and M_2** :

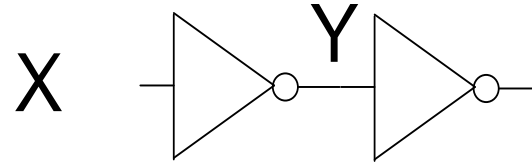
$$R_{PD} \cong 2.5K\Omega$$

$$R_{PU} \cong 3R_{PD} = 7.5K\Omega$$

$$C_{IN} \cong 2fF$$

Propagation Delay in Static CMOS Family

(Review from earlier discussions)

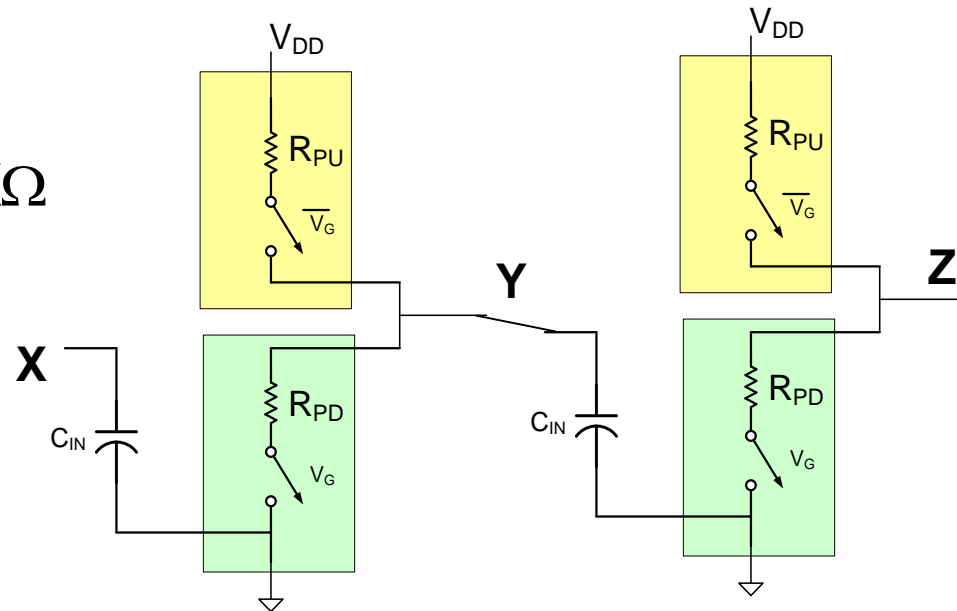


In typical process with **Minimum-sized M_1 and M_2** :

$$R_{PD} \cong 2.5K\Omega$$

$$R_{PU} \cong 3R_{PD} = 7.5K\Omega$$

$$C_{IN} \cong 2fF$$



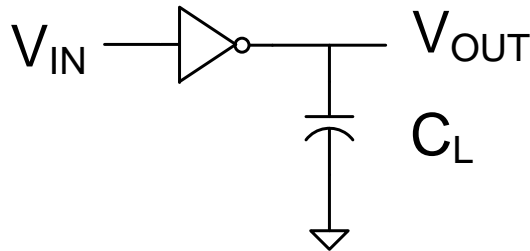
How long does it take for a signal to propagate from x to y?

Propagation Delay in Static CMOS Family

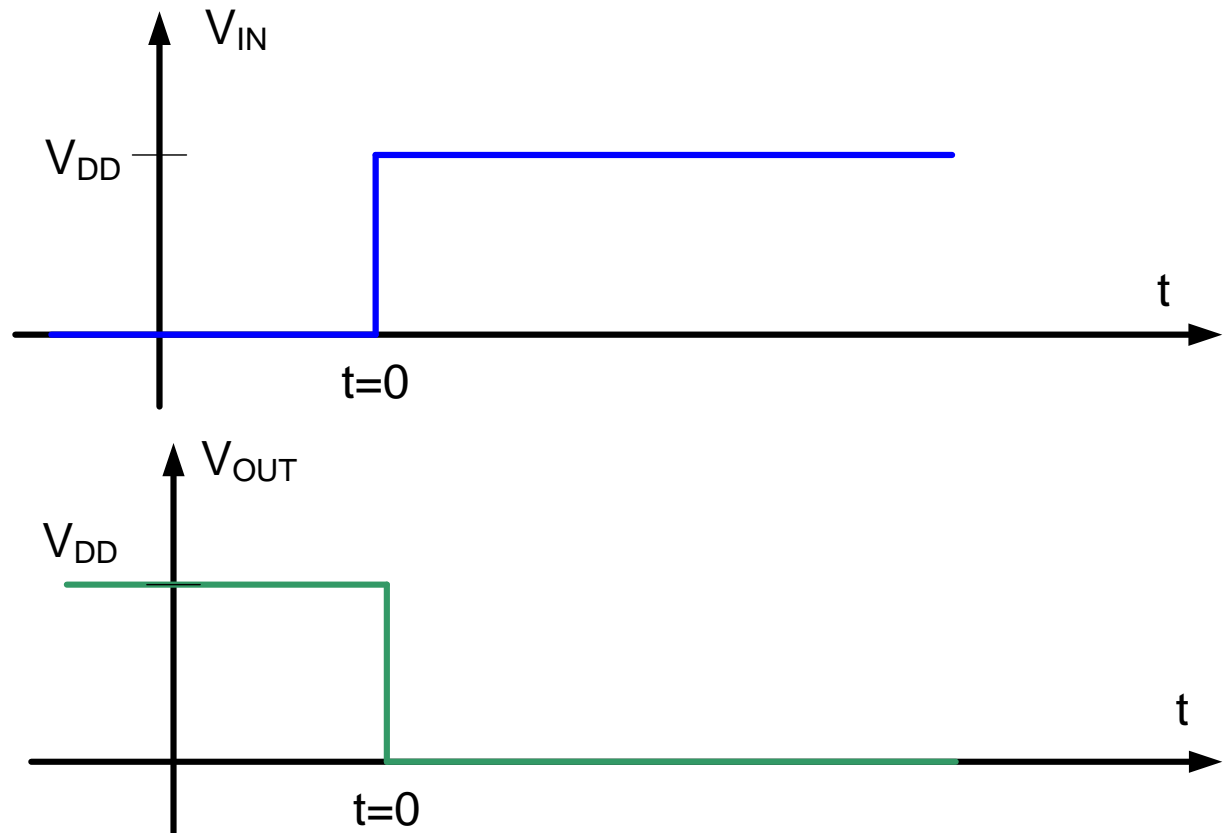
(Review from earlier discussions)

Consider:

For HL output transition, C_L charged to V_{DD}



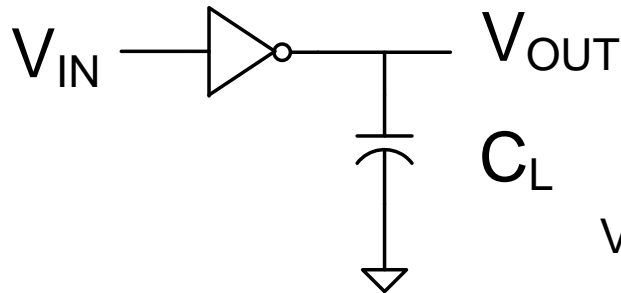
Ideally:



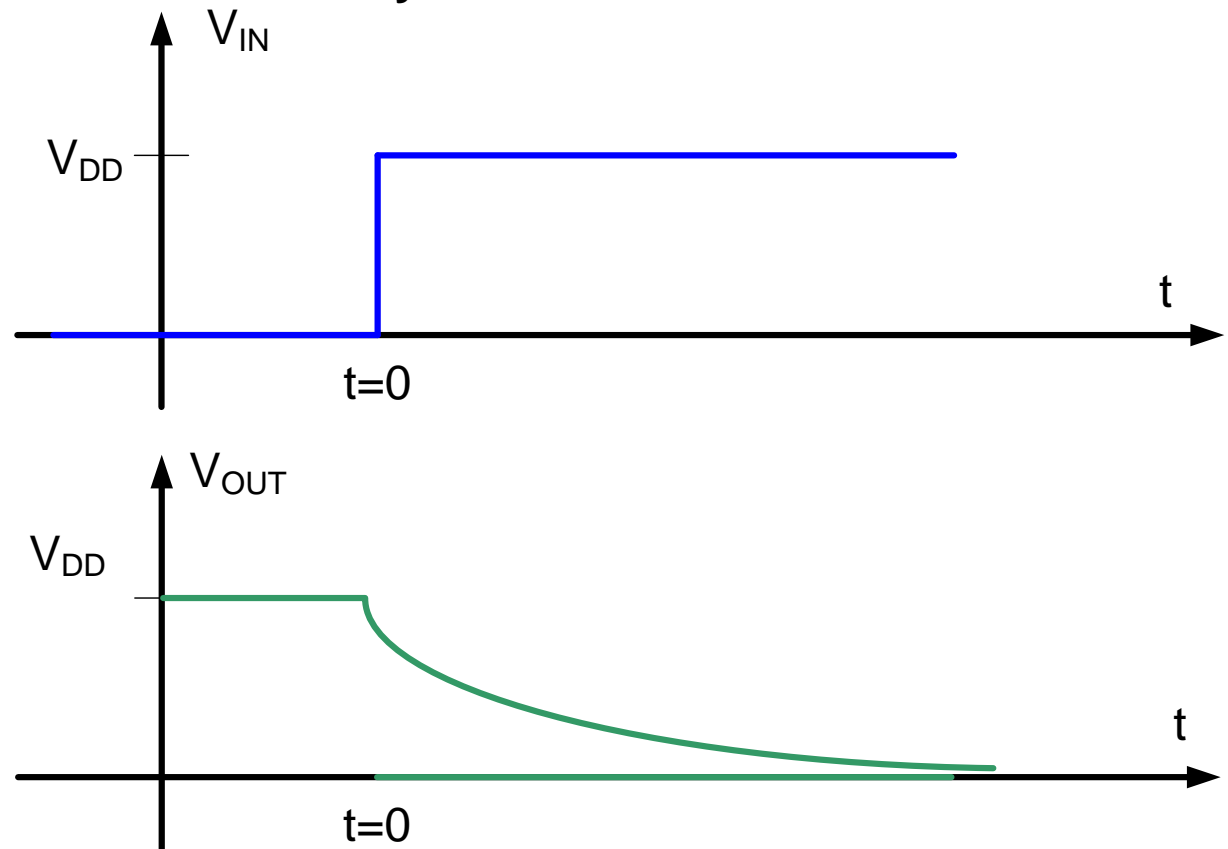
Propagation Delay in Static CMOS Family

(Review from earlier discussions)

For HL output transition, C_L charged to V_{DD}



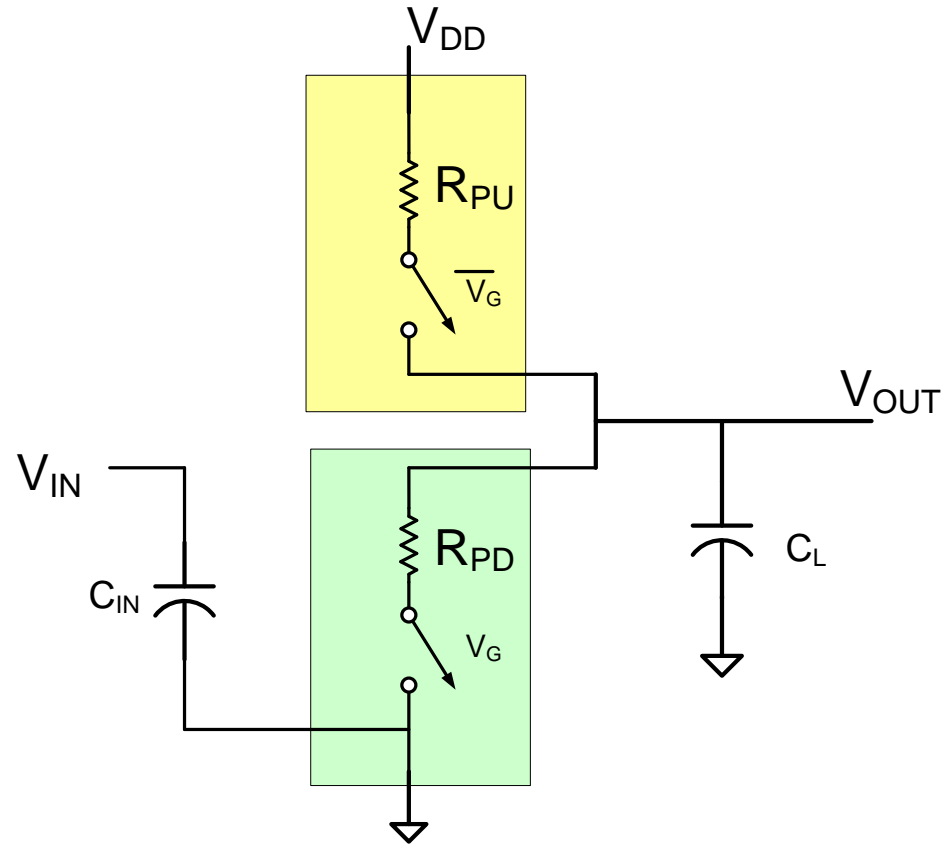
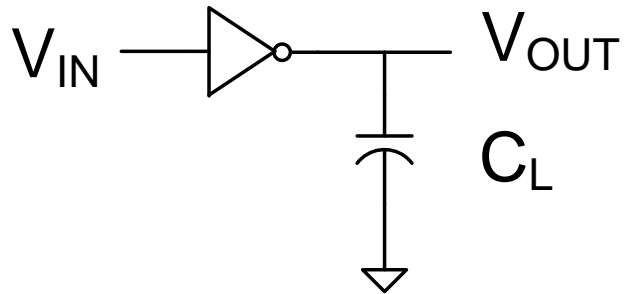
Actually:



What is the transition time t_{HL} ?

Propagation Delay in Static CMOS Family

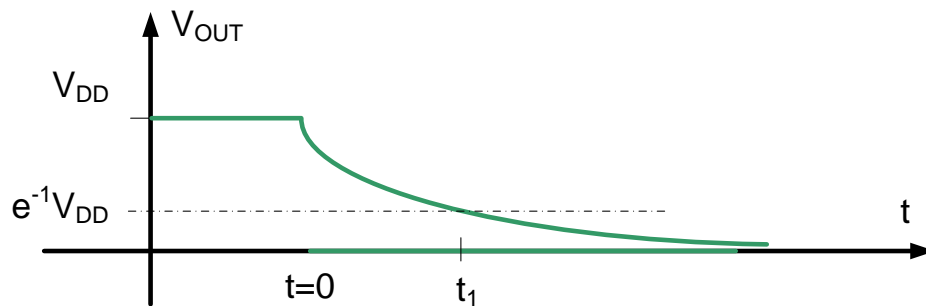
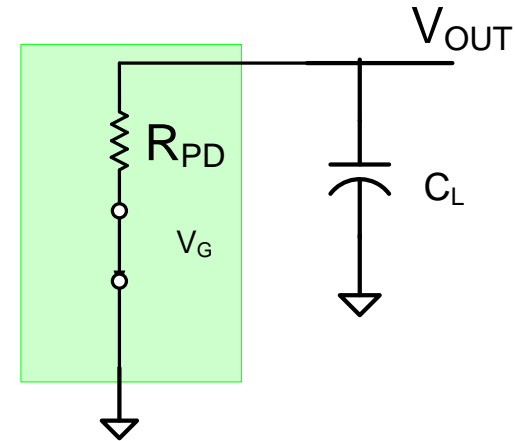
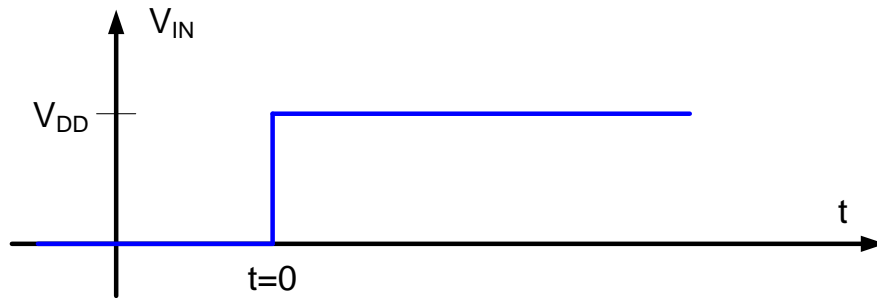
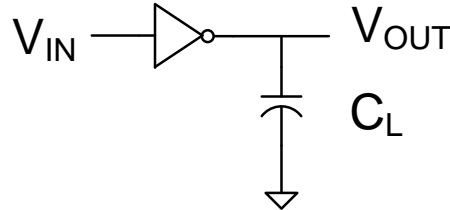
(Review from earlier discussions)



Propagation Delay in Static CMOS Family

(Review from earlier discussions)

For HL output transition, C_L charged to V_{DD}



$$V_{OUT}(t) = F + (I - F)e^{\frac{-t}{\tau}} = 0 + (V_{DD} - 0)e^{\frac{-t}{R_{PD}C_L}}$$

$$\frac{V_{DD}}{e} = V_{DD}e^{\frac{-t_1}{R_{PD}C_L}}$$

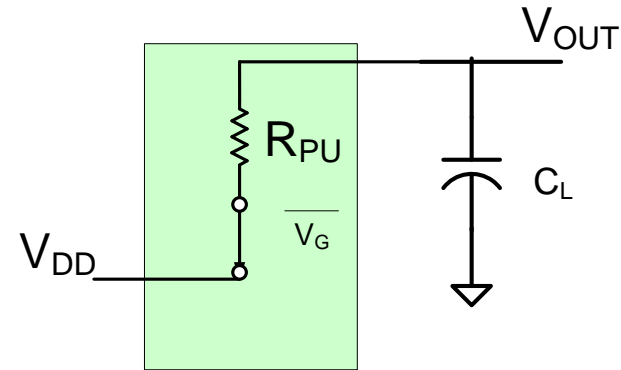
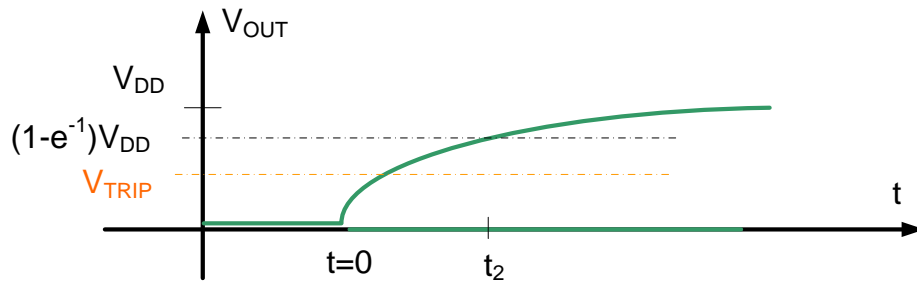
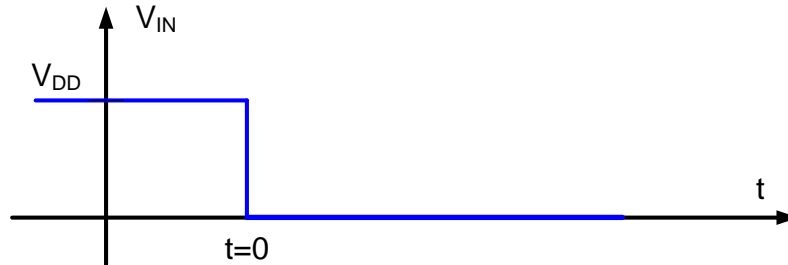
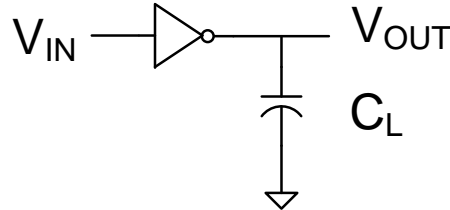
$$t_1 = R_{PD}C_L$$

If V_{TRIP} is close to $V_{DD}/2$, t_{HL} is close to t_1

Propagation Delay in Static CMOS Family

(Review from earlier discussions)

For HL output transition, C_L charged to V_{DD}



$$t_{LH} \cong t_2 = R_{PU} C_L$$

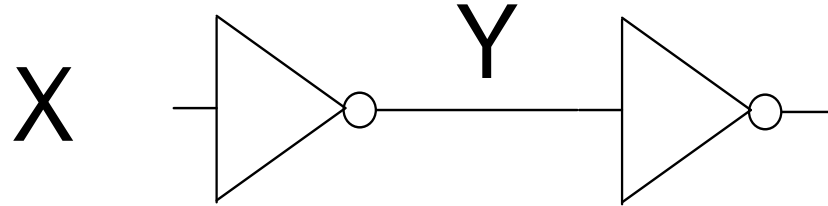
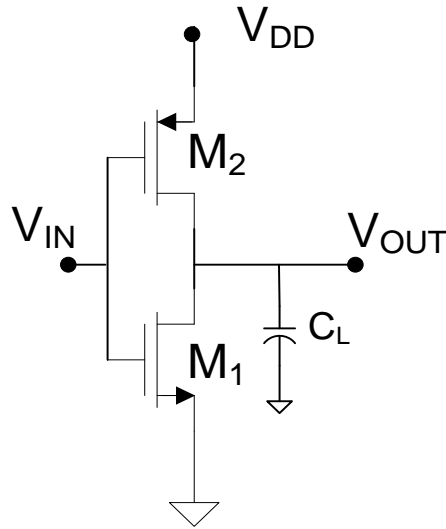
Summary: $t_{LH} \cong R_{PU} C_L$

$$t_{HL} \cong R_{PD} C_L$$

For V_{TRIP} close to $V_{DD}/2$

Propagation Delay in Static CMOS Family

(Review from earlier discussions)



In typical process with **Minimum-sized M_1 and M_2** :

$$t_{HL} \cong R_{PD}C_L \cong 2.5K \cdot 2fF = 5ps$$

$$t_{LH} \cong R_{PU}C_L \cong 7.5K \cdot 2fF = 15ps$$

(Note: This C_{ox} is somewhat larger than that in the 0.5u ON process)

Note: LH transition is much slower than HL transition

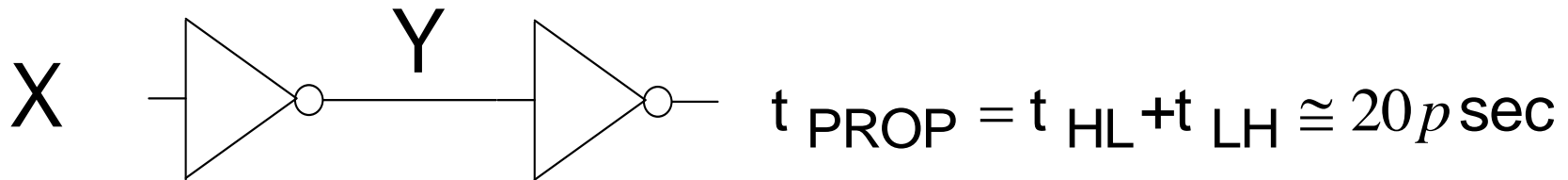
Propagation Delay in Static CMOS Family

Defn: The Propagation Delay of a gate is defined to be the sum of t_{HL} and t_{LH} , that is, $t_{PROP} = t_{HL} + t_{LH}$

$$t_{PROP} = t_{HL} + t_{LH} \cong C_L (R_{PU} + R_{PD})$$

Propagation delay represents a fundamental limit on the speed a gate can be clocked

For basic two-inverter cascade in static 0.5um CMOS logic



Propagation Delay in Static CMOS Family

$$t_{PROP} = t_{HL} + t_{LH} \cong C_L (R_{PU} + R_{PD})$$

$$R_{PD} = \frac{L_1}{\mu_n C_{OX} W_1 (V_{DD} - V_{Tn})} \quad R_{PU} = \frac{L_2}{\mu_p C_{OX} W_2 (V_{DD} + V_{Tp})} \quad C_{IN} = C_{OX} (W_1 L_1 + W_2 L_2)$$

$$\text{If } V_{Tn} = -V_{Tp} = V_T$$

$$t_{PROP} = C_{OX} (W_1 L_1 + W_2 L_2) \left(\frac{L_1}{m_n C_{OX} W_1 (V_{DD} - V_T)} + \frac{L_2}{m_p C_{OX} W_2 (V_{DD} - V_T)} \right)$$

$$\text{If } L_2 = L_1 = L_{min}, m_n = 3m_p,$$

$$t_{PROP} = \frac{L_{min}^2}{m_n (V_{DD} - V_T)} (W_1 + W_2) \left(\frac{1}{W_1} + \frac{3}{W_2} \right) = \frac{L_{min}^2}{m_n (V_{DD} - V_T)} \left(4 + \frac{W_2}{W_1} + 3 \frac{W_1}{W_2} \right)$$

For min size:

$$W_2 = W_1 = W_{min}$$

$$t_{PROP} = \frac{8L_{min}^2}{m_n (V_{DD} - V_T)}$$

For equal rise/fall:

$$W_2 = 3W_1$$

$$t_{PROP} = \frac{8L_{min}^2}{m_n (V_{DD} - V_T)}$$

For min delay:

$$W_2 = \sqrt{3}W_1 \quad (4 + 2\sqrt{3}) \cong 7.5$$

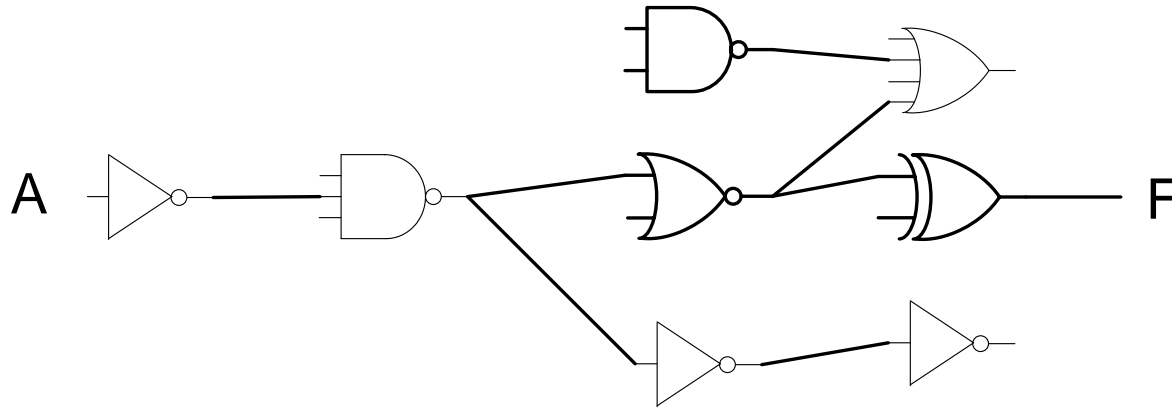
$$t_{PROP} = \frac{(4 + 2\sqrt{3})L_{min}^2}{m_n (V_{DD} - V_T)}$$

Approximate BSIM values

process	Lmin	u	VT	VDD	Wmin
500	600	34	0.7	5	900
180	180	35	0.4	1.8	180
130	130	59	0.33	1.3	130
90	100	55	0.26	1.1	100
65	65	49	0.22	1	65
45	45	44	0.22	0.9	45

For min L transistors, mobility will saturate as field strength reaches a certain level.

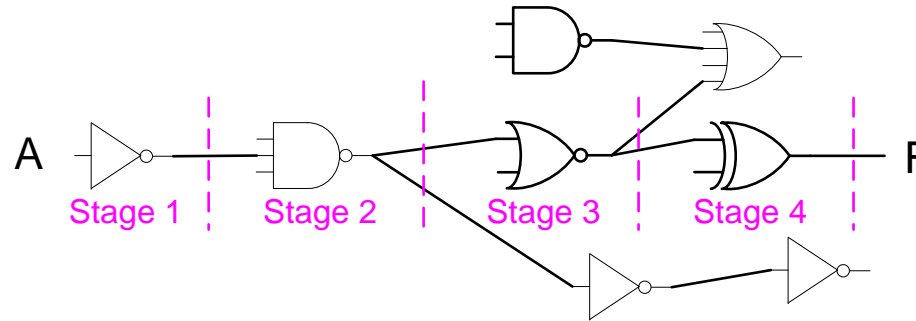
Propagation Delay in Static CMOS Family



The propagation delay through k levels of logic is approximately the sum of the individual delays in the same path

Propagation Delay in Static CMOS Family

Example:



$$t_{HL} = t_{HL4} + t_{LH3} + t_{HL2} + t_{LH1}$$

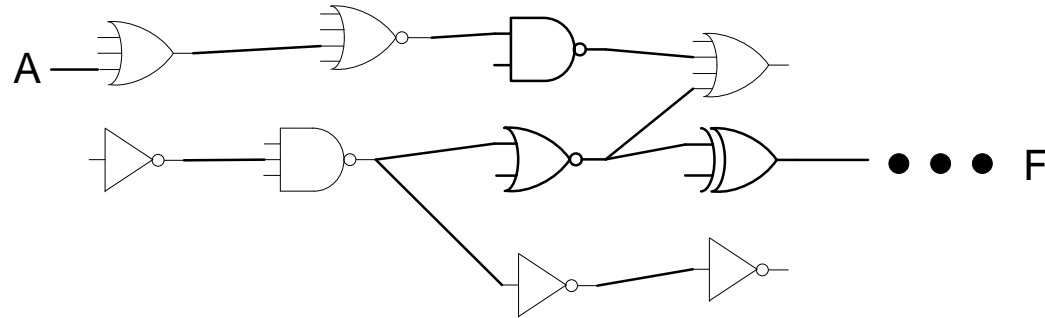
$$t_{LH} = t_{LH4} + t_{HL3} + t_{LH2} + t_{HL1}$$

$$t_{PROP} = t_{LH} + t_{HL} = (t_{LH4} + t_{HL3} + t_{LH2} + t_{HL1}) + (t_{HL4} + t_{LH3} + t_{HL2} + t_{LH1})$$

$$t_{PROP} = t_{LH} + t_{HL} = (t_{LH4} + t_{HL4}) + (t_{LH3} + t_{HL3}) + (t_{LH2} + t_{HL2}) + (t_{LH1} + t_{HL1})$$

$$t_{PROP} = t_{PROP4} + t_{PROP3} + t_{PROP2} + t_{PROP1}$$

Propagation Delay in Static CMOS Family



Propagation through k levels of logic

$$t_{HL} \cong t_{HLk} + t_{LH(k-1)} + t_{HL(k-2)} + \dots + t_{XY1}$$

$$t_{LH} \cong t_{LHk} + t_{HL(k-1)} + t_{LH(k-2)} + \dots + t_{YX1}$$

where x=H and Y=L if k odd and X=L and Y=h if k even

$$t_{PROP} = \sum_{i=1}^k t_{PROP_i}$$

Will return to propagation delay after we discuss device sizing

Digital Circuit Design

- Hierarchical Design
 - Basic Logic Gates
 - Properties of Logic Families
 - Characterization of CMOS Inverter
 - Static CMOS Logic Gates
 - Ratio Logic
 - Propagation Delay
 - Simple analytical models
 - Elmore Delay
 - Sizing of Gates
- Propagation Delay with Multiple Levels of Logic
 - Optimal driving of Large Capacitive Loads
 - Power Dissipation in Logic Circuits
 - Other Logic Styles
 - Array Logic
 - Ring Oscillators

→ **done**

→ **partial**

Question:

?

?

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?

?

Why is $|V_{Tp}| \approx V_{Tn} \approx V_{DD}/5$ in many processes ?

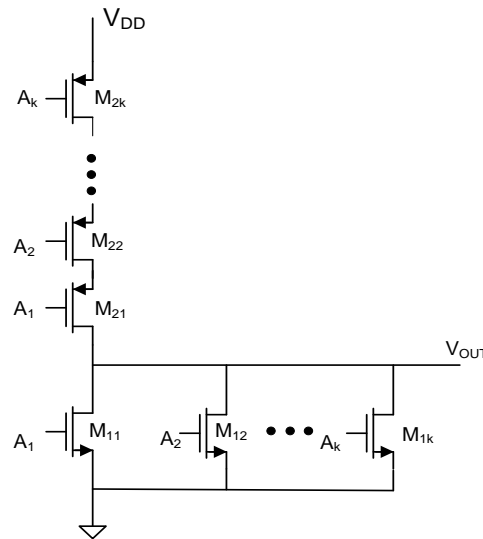
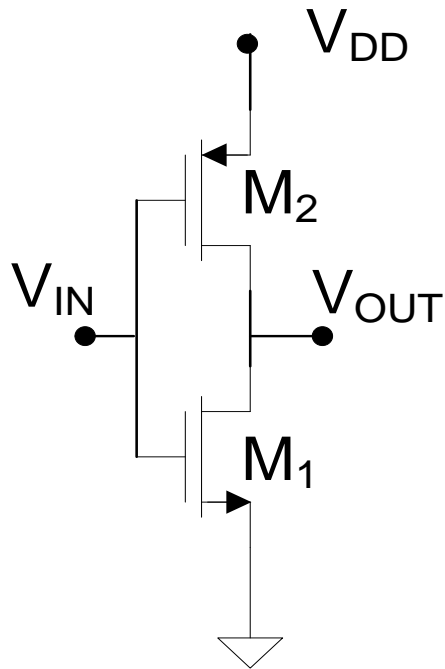
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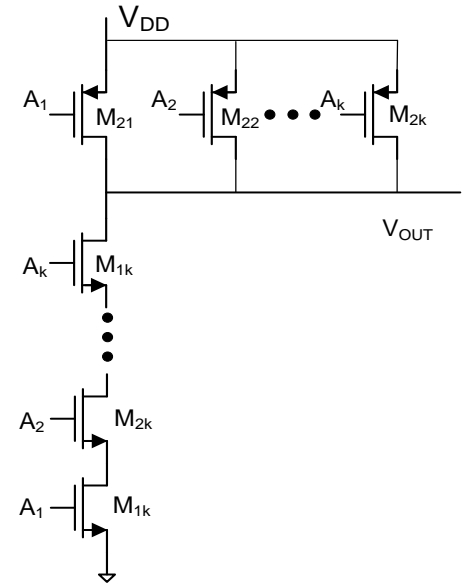
Device Sizing



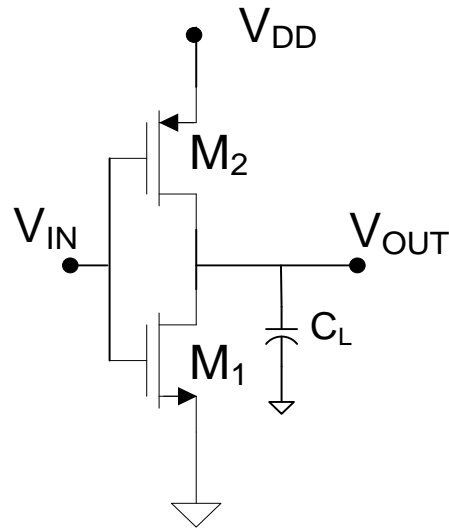
Strategies?

Degrees of Freedom?

Will consider the inverter first



Device Sizing

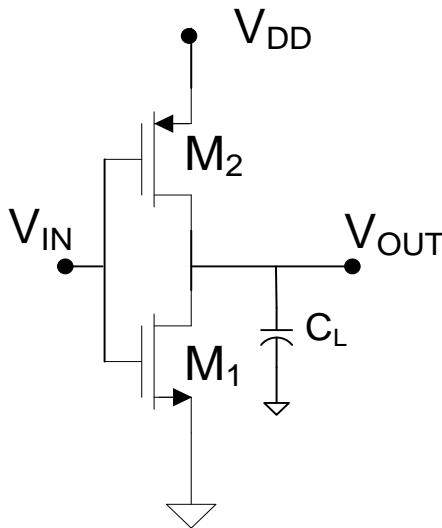


Degrees of Freedom?

Strategies?

Device Sizing

- Since not ratio logic, V_H and V_L are independent of device sizes for this inverter
- With $L_1=L_2=L_{\min}$, there are 2 degrees of freedom (W_1 and W_2)



Sizing Strategies

- Minimum Size
- Fixed V_{TRIP}
- Equal rise-fall times
(equal worst-case rise and fall times)
- Minimum power dissipation
- Minimum time required to drive a given load
- Minimum input capacitance

End of Lecture 39